

| | | |
|--|--|---------------------------------|
| LIST OF PUBLICATIONS CITED BY APPLICANT | <u>Attorney Docket No.</u> SEL 174 | <u>Serial No.</u> 09/544,801 |
| | <u>Applicant</u> Shunpei YAMAZAKI et al | |
| | <u>Filing Date</u> April 7, 2000 | <u>Group</u> 2826 |

US PATENT DOCUMENTS

| *EXAMINER INITIAL | DOCUMENT NUMBER | DATE | NAME | | |
|-------------------|--------------------|------------|----------------|--|--|
| /F.E./ | US 2006/0249733 A1 | 11/09/2006 | Yamazaki et al | | |
| /F.E./ | US 2006/0261338 A1 | 11/23/2006 | Yamazaki et al | | |

FOREIGN PATENT DOCUMENTS

| | DOCUMENT NUMBER | DATE | COUNTRY | English Abstract | English Translation |
|--|-----------------|------|---------|------------------|---------------------|
| | | | | | |

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

(Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.) date, pages(s), volume-issue number(s), publisher, city and/or country where published).

| | |
|--|--|
| | |
|--|--|

EXAMINER: /Fazli Erdem/

DATE CONSIDERED: 05/29/2008

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP form. Draw line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /F.E./